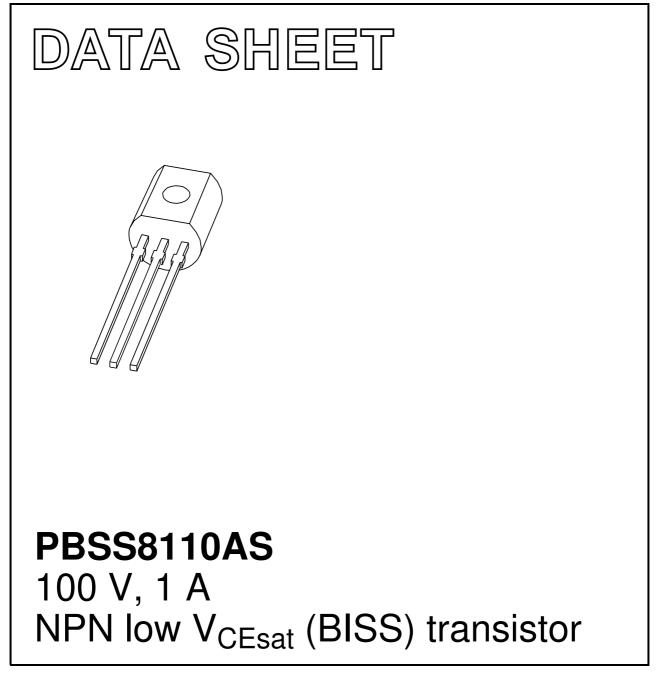
DISCRETE SEMICONDUCTORS



Product data sheet Supersedes data of 2003 Dec 03 2004 Aug 10



100 V, 1 A NPN low V_{CEsat} (BISS) transistor

FEATURES

- SOT54 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- Higher efficiency leading to less heat generation.

APPLICATIONS

- Automotive 42 V power
- Telecom infrastructure
- General industrial applications
- Power management
 - DC/DC converters
 - Supply line switching
 - Battery charger
 - LCD backlighting.
- Peripheral drivers
 - Generic driver (e.g. lamps and LEDs)
 - Inductive load driver (e.g. relays, buzzers and motors).

DESCRIPTION

NPN low $V_{\mbox{\scriptsize CEsat}}$ BISS transistor in a SOT54 plastic package.

QUICK REFERENCE DATA

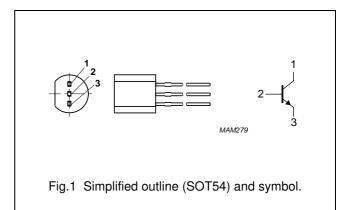
SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	100	V
I _C	collector current (DC)	1	А
I _{CM}	peak collector current 3		А
R _{CEsat}	equivalent on-resistance	200	mΩ

MARKING

TYPE NUMBER	MARKING CODE	
PBSS8110AS	S8110AS	

PINNING

PIN	DESCRIPTION	
1	collector	
2	base	
3	emitter	



ORDERING INFORMATION

TYPE NUMBER		PACKAGE				
ITPE NOMBER	NAME DESCRIPTION VERS					
PBSS8110AS	_	plastic single-ended leaded (through hole) package; 3 leads	SOT54			

PBSS8110AS

100 V, 1 A NPN low V_{CEsat} (BISS) transistor

PBSS8110AS

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	-	120	V
V _{CEO}	collector-emitter voltage	open base	_	100	V
V _{EBO}	emitter-base voltage	open collector	_	5	V
I _C	collector current (DC)		_	1	А
I _{CM}	peak collector current	T _{j max}	-	3	А
I _B	base current (DC)		_	300	mA
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$; note 1	_	830	mW
Tj	junction temperature		_	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Note

1. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; standard footprint.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT	
R _{th(j-a)}	thermal resistance from junction to ambient	in free air; note 1	150	K/W	

Note

1. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; standard footprint.

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PBSS8110AS

CHARACTERISTICS

 T_j = 25 °C unless otherwise specified.

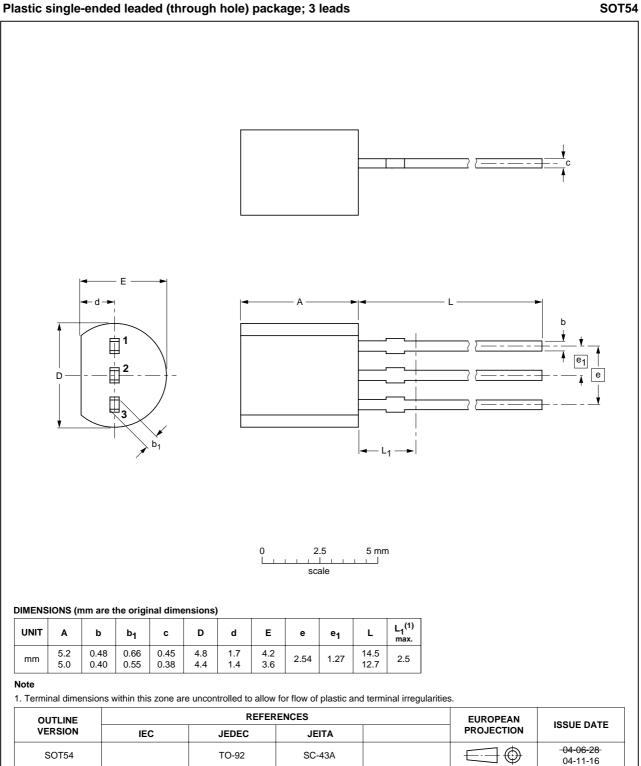
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector cut-off current	$V_{CB} = 80 \text{ V}; \text{ I}_{E} = 0$	_	_	100	nA
		$V_{CB} = 80 \text{ V}; I_E = 0; T_j = 150 \text{ °C}$	-	-	50	μA
I _{CES}	collector cut-off current	$V_{CE} = 80 \text{ V}; \text{ V}_{BE} = 0$	-	-	100	nA
I _{EBO}	emitter cut-off current	$V_{EB} = 4 \text{ V}; I_{C} = 0$	-	-	100	nA
h _{FE}	DC current gain	$V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ mA}$	150	-	-	
		V _{CE} = 10 V; I _C = 250 mA	150	-	500	
		V _{CE} = 10 V; I _C = 0.5 A; note 1	100	-	-	
		V _{CE} = 10 V; I _C = 1 A; note 1	80	_	-	
V _{CEsat}	collector-emitter saturation	I _C = 100 mA; I _B = 10 mA	-	-	40	mV
	voltage	$I_{\rm C} = 500 \text{ mA}; I_{\rm B} = 50 \text{ mA}$	-	-	120	mV
		I _C = 1 A; I _B = 100 mA	_	_	200	mV
R _{CEsat}	equivalent on-resistance	I _C = 1 A; I _B = 100 mA; note 1	-	165	200	mΩ
V _{BEsat}	base-emitter saturation voltage	I _C = 1 A; I _B = 100 mA; note 1	-	-	1.05	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = 10 \text{ V}; \text{ I}_{C} = 1 \text{ A}$	_	_	0.9	V
f _T	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 50 \text{ mA}; f = 100 \text{ MHz}$	100	-	-	MHz
Cc	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	_	_	7.5	pF

Note

1. Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

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PACKAGE OUTLINE



PBSS8110AS

100 V, 1 A NPN low V_{CEsat} (BISS) transistor

PBSS8110AS

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

Notes

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NXP Semiconductors

Customer notification

This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content, except for package outline drawings which were updated to the latest version.

Contact information

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